

#11 23 1563 3/30/94

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: ALUMOT DAVID , et al

Assignee: APPLIED MATERIALS, INC.

Title: TWO PHASE OPTICAL INSPECTION METHOD AND APPARATUS FOR DEFECT

Serial No.: 08/984,558

Batch No. N30

Filed: 03DE1997

Group Art Unit: 2721

Attorney Docket No.: 002187/C1/USA/PDC/ORBOT

Examiner: Andrew W. Johns

Santa Clara, California
March 16 1999

LETTER TO THE OFFICIAL DRAFTSMAN

The Commissioner of Patents and Trademarks
Washington, D.C. 20231

March 15, 1999

Sir:

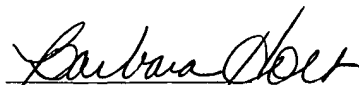
Enclosed are Forty (40) sheets of formal drawings for the above-identified patent application.

Respectfully submitted,



Joseph Bach
Registration No. 37,771

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner of Patents and Trademarks, Washington, D.C. 20231 on March 16, 1999.


Barbara Holt

RECEIVED
Publishing Division

MAR 17 1999